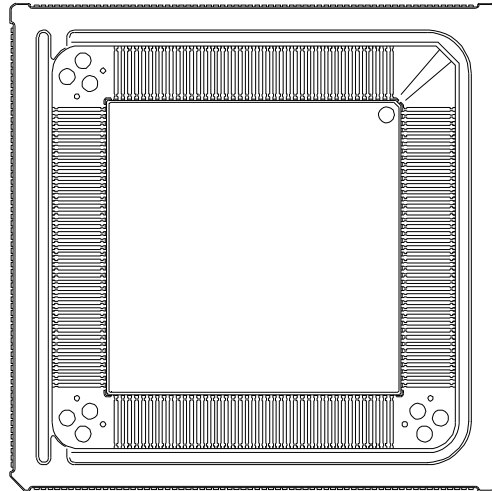
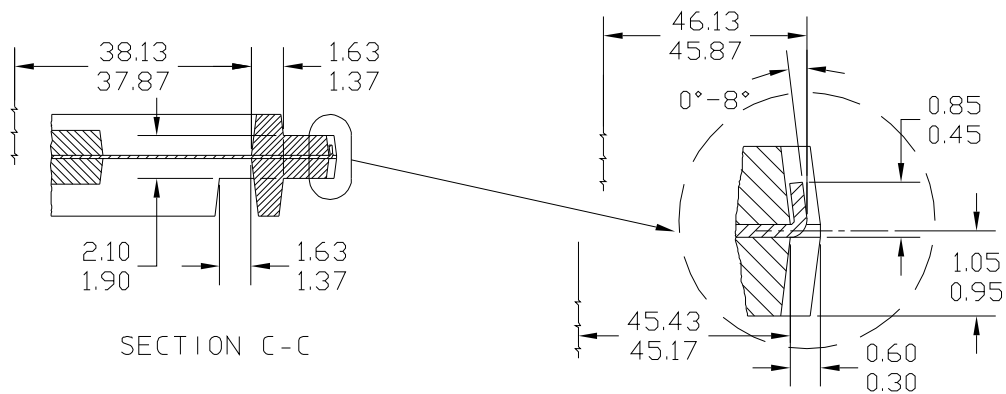
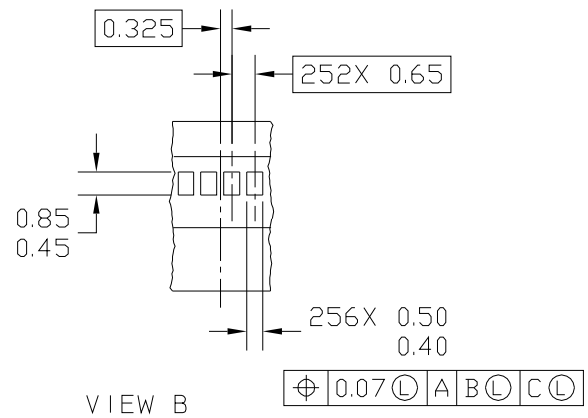
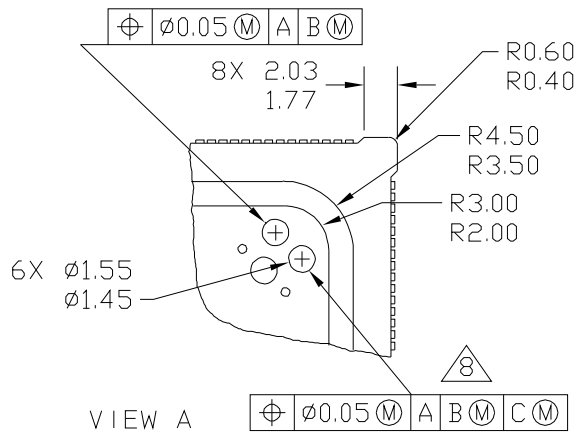


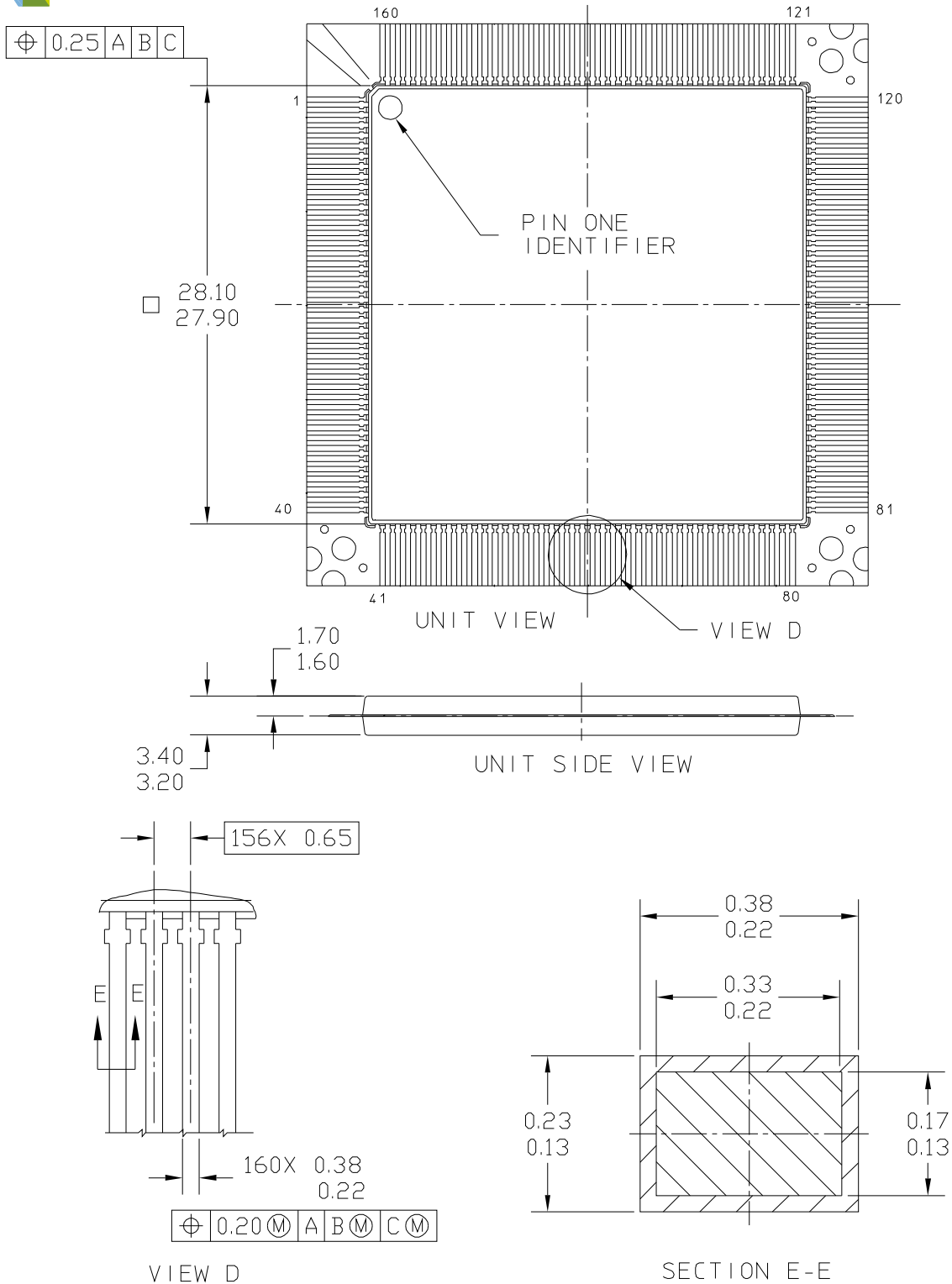
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	STANDARD: NON-JEDEC	
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BOTTOM VIEW OF UNIT  
IN MOLDED CARRIER RING



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NOTES:

1. ALL DIMENSIONS AND TOLERANCES CONFORM TO ASME Y14.5M-1994.

2. CONTROLLING DIMENSION: MILLIMETER

3. DIMENSION DOES NOT INCLUDE MOLD PROTRUSION. ALLOWABLE MOLD PROTRUSION IS 0.20 PER SIDE.

4. DIMENSIONS INCLUDE MOLD MISMATCH, AND ARE MEASURED AT THE PARTING LINE.

5. UNLESS OTHERWISE SPECIFIED DIMENSIONS ARE SYMMETRICAL ABOUT CENTERLINES.

6. DATUM HOLES B AND C ARE TO BE USED FOR TRIM, FORM AND EXCISE OF THE MOLDED PACKAGE ONLY.

7. HOLES Q1 AND Q2 ARE TO BE USED FOR ELECTRICAL TESTING ONLY.

8. NON-DATUM HOLES ONLY.

9. APPLIES TO RING AND PACKAGE FEATURES.

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